

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	23486	wafer near5 (test\$6 or reusable or reused or reclaim\$6 or (re adj (used or usable or claim\$6)))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/15 15:53
L2	1539	1 and (((polysilicon or polySi or (poly adj (Si or silicon))) near15 (polish\$6 or CMP)) or (single adj crystal))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/15 15:39
L3	1500	2 and (test\$6 or check\$6 or monitor\$6 or inspect\$6 or measur\$6 or calibrat\$6 or validat\$6 or evaluat\$6 or detect\$6 or verif\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/15 15:53
L4	1453	3 and (@ad<"20031119" or @rlad<"20031119")	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/15 15:43
L5	1112	4 and (coat\$6 or deposit\$6) and (remov\$6 or refresh\$6 or replac\$6 or recondition\$6 or (re adj (mov\$6 or fresh\$6 or replac\$6 or condition\$6)))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/15 15:45
L6	159	4 and sacrificial	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/15 15:45
L7	1115	5 or 6	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/15 15:46
L10	695	wafer near5 (reusable or reused or reclaim\$6 or (re adj (used or usable or claim\$6)))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/15 15:53
L11	109	7 and 10	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/15 15:53